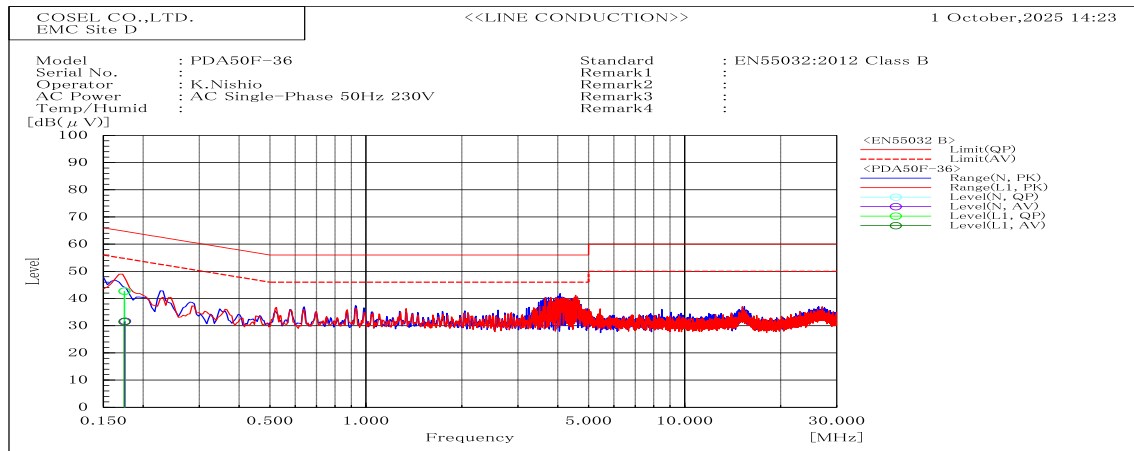
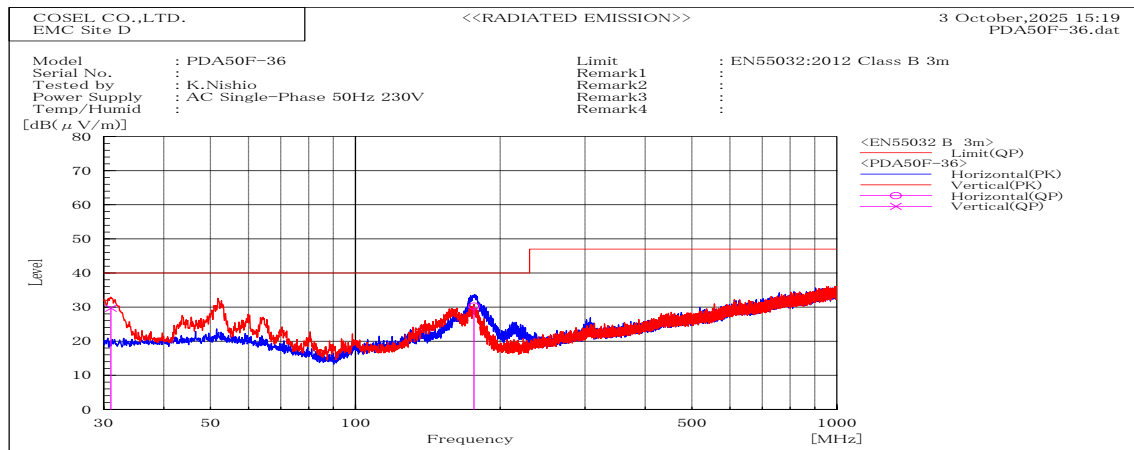


DATA SHEET		Date	03-Oct-25
Model	PDA50F-36	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	K.Nishio



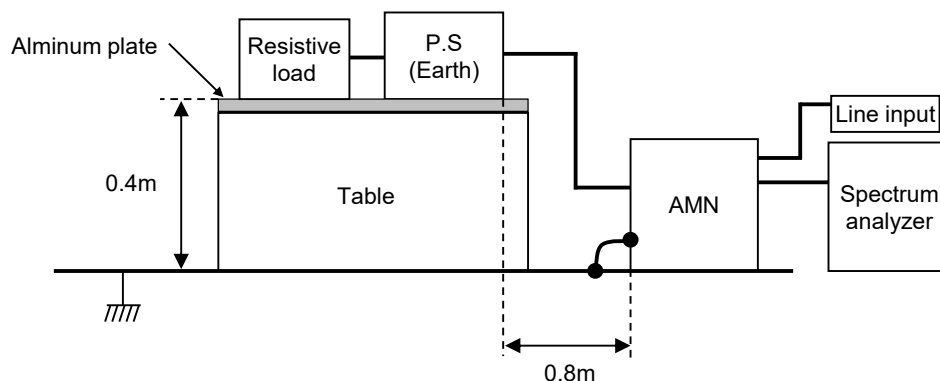
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.175	N	42.8	31.7	64.7	54.7	21.9	23	Pass	
0.175	L1	42.7	31.5	64.7	54.7	22	23.2	Pass	



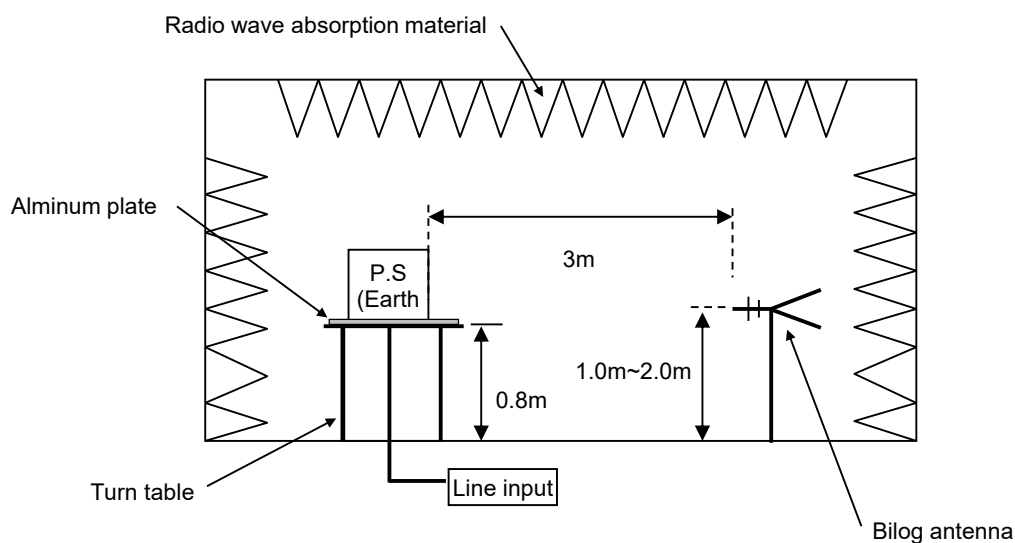
Frequency MHz	Polarization	Stability	Level dB(μV/m)		Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP		QP				
31.069	V	Stable	29.7	40	10.3	Pass	100.2	357.9		
176.361	H	Stable	30.3	40	9.7	Pass	199.7	359.1		

DATA SHEET		Date	03-Oct-25
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	K.Nishio

1. Line conduction

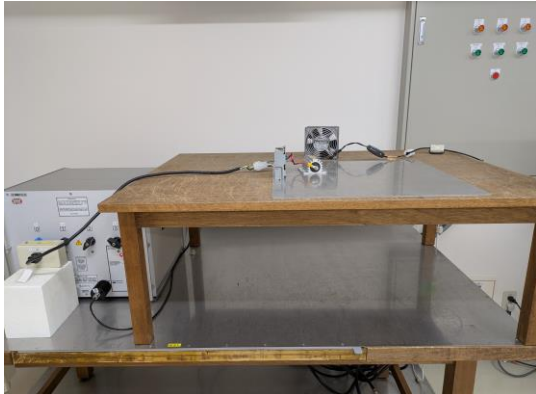


2. Radiated emission



Conditions

Test : EMI
Model Name : PDA50F-36

1.LINE CONDUCTION**2.RADIATED EMISSION**